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Docket No.: 060188-0555 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

If re Application of

Customer Number: 53080

Ashinao HARADA

APR 3 0 2007

Confirmation Number: 1545

Application No.: 10/602,724

Patent No.: 7,157,780

Group Art Unit: 2826

Filed: June 25, 2003

Examiner: Fazli Erdem

For: SEMICONDUCTOR DEVICE AND METHOD FOR PRODUCING THE SAME

### **REQUEST FOR CERTIFICATE OF CORRECTION UNDER 37 CFR 1.322**

Mail Stop COC Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Certificate

MAY 0 3 2007

of Correction

Sir:

In reviewing the above-identified patent, a printing error was discovered therein requiring correction in order to conform the Official Record in the application.

The error noted is set forth on the two attached copies of form PTO-1050 Rev. 2-93 in the manner required by the Commissioner's Notice.

Specifically, on the title page of the Letters Patent, under section "(56) References Cited, U.S. PATENT DOCUMENTS", add – US 6,737,716 B1 05/2004 Matsuo et al. –. The references was cited in the first office action dated August 19, 2004, but not listed in PTO form 892. For your immediate reference a photocopy of the office action dated August 19, 2004 is attached.

The change requested herein occurred as a result of printing the Letters Patent and the Certificate should be issued without expense under Rule 322 of the Rules of Practice. Accordingly, Applicants request issuance of the Certificate of Correction.

Patent No.: 7,157,780

Please charge any shortage in fees due in connection with the filing of this paper to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Facsimile: 202.756.8087 **Date: April 30, 2007** 

Please recognize our Customer No. 53080 as our correspondence address.

# UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 7157780

DATED : January 02, 2007 INVENTOR(S) : Yoshinao HARADA

It is certified that an error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

On the title page of the Letters Patent,

Under section "(56) References Cited, U.S. PATENT DOCUMENTS", add – US 6,737,716 B1 05/2004 Matsuo et al. –

MAILING ADDRESS OF SENDER: McDermott Will & Emery LLP 600 13th Street, NW Washington, DC 20005 USA

PATENT NO. 7,157,750

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FORM PTO 1050 (Rev. 2-93)

# UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 7157780

DATED : January 02, 2007 INVENTOR(S) : Yoshinao HARADA

It is certified that an error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

On the title page of the Letters Patent,

Under section "(56) References Cited, U.S. PATENT DOCUMENTS", add – US 6,737,716 B1 05/2004 Matsuo et al. –

MAILING ADDRESS OF SENDER: McDermott Will & Emery LLP 600 13th Street, NW Washington, DC 20005 USA PATENT NO. 7,157,750

No. of add'l copies @ 50¢ per page

FORM PTO 1050 (Rev. 2-93)

# US006737716B1

### (12) United States Patent Matsuo et al.

(10) Patent No.:

US 6,737,716 B1

(45) Date of Patent:

May 18, 2004

#### (54) SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME

(75) Inventors: Kouji Matsuo, Yokohama (JP);

Tomohiro Saito, Yokohama (JP); Kyoichi Suguro, Yokohama (JP); Shinichi Nakamura, Yokohama (JP)

Assignee: Kabushiki Kaisha Toshiba, Kawashi

(JP)

Subject to any disclaimer, the term of this patent is extended or adjusted under 35

U.S.C. 154(b) by 0 days.

(21) Appl. No.: 09/492,780

(\*) Notice:

(22)Filed: Jan. 28, 2000

#### (30)Foreign Application Priority Data

Jan. 29, 1999	(JP)		11-022688
Feb. 19, 1999.	(JP)		11-041343
Sep. 21, 1999	(JP)	•••••	11-267207

(51) Int. Cl.<sup>7</sup> ...... H01L 29/76; H01L 31/062; H01L 23/48; H01L 29/12

U.S. Cl. ...... 257/406; 257/412; 257/413; 257/754; 257/755; 257/915

Field of Search ...... 257/406, 412, 257/413, 754, 755, 915

(56)References Cited

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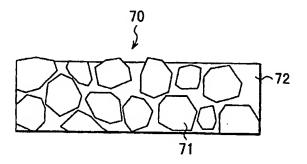
\* cited by examiner

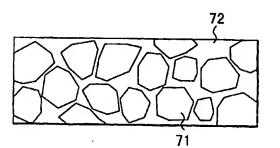
Primary Examiner—Long Pham Assistant Examiner-Shrinivas H. Rao (74) Attorney, Agent, or Firm-Finnegan, Henderson, Farabow, Garrett & Dunner, L.L.P.

#### (57)**ABSTRACT**

Disclosed is a method of manufacturing a semiconductor device, comprising forming a metal compound film directly or indirectly on a semiconductor substrate, forming a metalcontaining insulating film consisting of a metal oxide film or a metal silicate film by oxidizing the metal compound film, and forming an electrode on the metal-containing insulating film.

7 Claims, 25 Drawing Sheets







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FIRST NAMED INVENTOR ATTORNEY DOCKET NO. CONFIRMATION NO APPLICATION NO. FILING DATE 10/602,724 06/25/2003 Yoshinao Harada 60188-555 1545 EXAMINER 08/19/2004 McDermott, Will & Emery ERDEM, FAZLI 600 13th Street, N.W. ART UNIT PAPER NUMBER Washington, DC 20005-3096 2826

DATE MAILED: 08/19/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)
PE	10/602,724	HARADA, YOSHINAO
Office Action Summary	Examiner	Art Unit
0 2007 = )	Fazli Erdem	2826
SIThe MAILING DATE of this communication		ith the correspondence address
i onoqual icepiy		
SHORTENED STATUTORY PERIOD FOR RE THE MAILING DATE OF THIS COMMUNICATIO  - Extensions of time may be available under the provisions of 37 CFF effer SIX (6) MONTHS from the mailing date of this communication  - If the period for reply specified above is less than thirty (30) days, a  - If NO period for reply is specified above, the maximum statutory per  - Failure to reply within the set or extended period for reply will, by st Any reply received by the Office later than three months after the m earned patent term adjustment. See 37 CFR 1.704(b).	T1.136(a). In no event, however, may a r reply within the statutory minimum of thin riod will apply and will expire SIX (6) MON	eply be timely filed y (30) days will be considered timely. THS from the mailing date of this communication.
Status		
1) Responsive to communication(s) filed on 2:	5 June 2003	
	his action is non-final.	
3) Since this application is in condition for allo	wance except for formal matte	ers. prosecution as to the medite is
closed in accordance with the practice unde	er Ex parte Quayle, 1935 C.D.	. 11, 453 O.G. 213.
Disposition of Claims		
4) Claim(s) 1-31 is/are pending in the application		
4a) Of the above daim(s) is/are withd		
5) Claim(s) is/are allowed.	rawn from consideration.	
6) Claim(s) 1 and 6-31 is/are rejected.		
7) Claim(s) 2-5 is/are objected to.		
8) Claim(s) are subject to restriction and	d/or election requirement.	
Application Papers		
9)☐ The specification is objected to by the Exami	ner	
10) The drawing(s) filed on is/are: a) a	ccepted or b) objected to b	v the Examiner
Applicant may not request that any objection to the	ne drawing(s) be held in abeyand	e. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the corre	ection is required if the drawing(s	s) is objected to. See 37 CFR 1 121(d)
11) The oath or declaration is objected to by the	Examiner. Note the attached	Office Action or form PTO-152.
riority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for foreign	an priority under 35 U.S.C. & :	119(a)-(d) or (f)
a) ☐ All b) ☐ Some * c) ☐ None of:	,p, 2.1.20, 00 0.0,0. 3	110(a)-(a) 01 (1).
1. Certified copies of the priority docume.	nts have been received.	
2. Certified copies of the priority docume	nts have been received in Ap	plication No
3. Copies of the certified copies of the pri	ority documents have been re	eceived in this National Stage
application from the International Bure	au (PCT Rule 17.2(a)).	
* See the attached detailed Office action for a lis	it of the certified copies not re	eceived.
Notice of References City of (NTC 200)		
Notice of References Cited (PTO-892)  Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) Interview Sun Paper No(s)/N	nmary (PTO-413) Mail Date,
Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08	s) 5) U Notice of Info	rmal Patent Application (PTO-152)
Paper No(s)/Mail Date <u>06/25/2003</u> .	6) 🔲 Other:	·

Office Action Summary

MAY = 7. 2007

Part of Paper No./Mail Date 08092004

Art Unit: 2826

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#### Double Patenting

4. The nonstatutory double patenting rejection is based on a judicially created doctrine grounded in public policy (a policy reflected in the statute) so as to prevent the unjustified or improper timewise extension of the "right to exclude" granted by a patent and to prevent possible harassment by multiple assignees. See In re Goodman, 11 F.3d 1046, 29 USPQ2d 2010 (Fed. Cir. 1993); In re Longi, 759 F.2d 887, 225 USPO 645 (Fed. Cir. 1985); In re Van Ornum, 686 F.2d 937, 214 USPQ 761 (CCPA 1982); In re Vogel, 422 F.2d 438, 164 USPQ 619 (CCPA 1970); and, In re Thorington, 418 F.2d 528, 163 USPQ 644 (CCPA 1969).

A timely filed terminal disclaimer in compliance with 37 CFR 1.321(c) may be used to overcome an actual or provisional rejection based on a nonstatutory double patenting ground provided the conflicting application or patent is shown to be commonly owned with this application. See 37 CFR 1.130(b).

Effective January 1, 1994, a registered attorney or agent of record may sign a terminal disclaimer. A terminal disclaimer signed by the assignee must fully comply with 37 CFR 3.73(b).

Claims 7-31 rejected under the judicially created doctrine of obviousness-type double patenting as being unpatentable over claims 1- of U.S. Patent No. 6,642,131. Although the conflicting claims are not identical, they are not patentably distinct from each other because in Claims 7-19, they both claim a method for producing a semiconductor device which comprises the steps of forming a high dielectric constant film containing a metal, oxygen and a predetermined substance on a substrate, performing a heat treatment with respect to the high dielectric constant film to diffuse silicon from the side of the substrate into the high dielectric constant film to form siliconcontaining high dielectric constant film and forming a conductive film for serving as a gate electrode on the silicon-containing high dielectric constant film. Regarding Claims 20-31, they both claim a method for producing a semiconductor device comprising the steps of forming a high dielectric constant film containing a metal, oxygen and hydrogen

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Page 4

film to diffuse silicon from the side of the substrate into the high dielectric constant film

in order to form a silicon-containing dielectric constant film and forming a conductive

on a substrate, performing a heat treatment with respect to the high dielectric constant

film for serving as a gate electrode on the silicon-containing high dielectric constant film.

Conclusion

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Fazli Erdem whose telephone number is (571) 272-1914.

The examiner can normally be reached on M - F 8:00 - 5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Nathan Flynn can be reached on (571) 272-1915. The fax phone number for

the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the

Patent Application Information Retrieval (PAIR) system. Status information for

published applications may be obtained from either Private PAIR or Public PAIR. Status

information for unpublished applications is available through Private PAIR only. For

more information about the PAIR system, see http://pair-direct.uspto.gov. Should you

have questions on access to the Private PAIR system, contact the Electronic Business

Center (EBC) at 866-217-9197 (toll-free).

FE

August 9, 2004

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